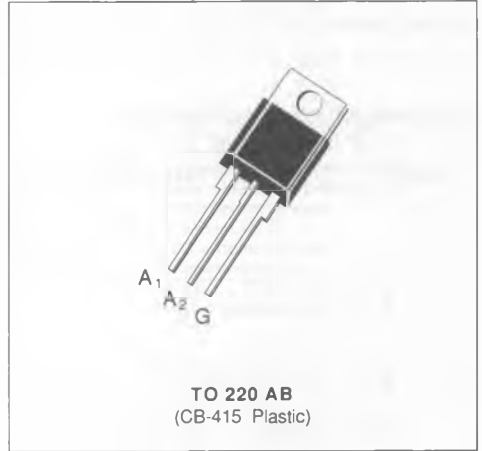




**SNUBBERLESS TRIACS**

- $I_{TRMS} = 6\text{ A}$  at  $T_c = 100\text{ }^\circ\text{C}$ .
- $V_{DRM} : 200\text{ V}$  to  $800\text{ V}$ .
- $I_{GT} = 50\text{ mA}$  (QI-II-III).
- GLASS PASSIVATED CHIP.
- HIGH SURGE CURRENT :  $I_{TSM} = 60\text{ A}$ .
- HIGH COMMUTATION CAPABILITY :  
( $di/dt$ )<sub>c</sub> >  $5\text{ A/ms}$  without snubber.



**DESCRIPTION**

New range suited for applications such as phase control and static switching on inductive or resistive load.

**ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter	Value	Unit
$I_{TRMS}$	RMS on-state current (360 ° conduction angle)	$T_c = 100\text{ }^\circ\text{C}$ 6	A
$I_{TSM}$	Non repetitive surge peak on-state current ( $T_j$ initial = $25\text{ }^\circ\text{C}$ )	$t = 8.3\text{ ms}$	63
		$t = 10\text{ ms}$	60
$I^2 t$	$I^2 t$ value	$t = 10\text{ ms}$	18
$di/dt$	Critical rate of rise of on-state current (1)	Repetitive $F = 50\text{ Hz}$	20
		Non Repetitive	100
$T_{stg}$ $T_j$	Storage and operating junction temperature range	- 40, + 150 - 40, + 125	$^\circ\text{C}$ $^\circ\text{C}$

Symbol	Parameter	BTB 06-					Unit
		200 BW	400 BW	600 BW	700 BW	800 BW	
$V_{DRM}$	Repetitive peak off-state voltage (2)	$\pm 200$	$\pm 400$	$\pm 600$	$\pm 700$	$\pm 800$	V

(1) Gate supply :  $I_g = 500\text{ mA} - di_g / dt = 1\text{ A} / \mu\text{s}$ .

(2)  $T_j = 125\text{ }^\circ\text{C}$ .

## THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
$R_{th(j-a)}$	Junction to ambient	60	$^{\circ}\text{C}/\text{W}$
$R_{th(j-c)}$ DC	Junction to case for DC	3.5	$^{\circ}\text{C}/\text{W}$
$R_{th(j-c)}$ AC	Junction to case for 360 $^{\circ}$ conduction angle ( $F = 50$ Hz)	2.7	$^{\circ}\text{C}/\text{W}$

## GATE CHARACTERISTICS (maximum values)

$P_{GM} = 40$  W ( $t = 10$   $\mu\text{s}$ )  $P_{G(AV)} = 1$  W  $I_{GM} = 4$  A ( $t = 10$   $\mu\text{s}$ )  $V_{GM} = 16$  V ( $t = 10$   $\mu\text{s}$ ).

## ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions			Quadrants	Min.	Typ.	Max.	Unit
$I_{GT}$	$T_j = 25$ $^{\circ}\text{C}$ Pulse duration $> 20$ $\mu\text{s}$	$V_D = 12$ V $R_L = 33$ $\Omega$		I-II-III	2		50	mA
$V_{GT}$	$T_j = 25$ $^{\circ}\text{C}$ Pulse duration $> 20$ $\mu\text{s}$	$V_D = 12$ V $R_L = 33$ $\Omega$		I-II-III			1.5	V
$V_{GD}$	$T_j = 125$ $^{\circ}\text{C}$ Pulse duration $> 20$ $\mu\text{s}$	$V_D = V_{DRM}$ $R_L = 3.3$ k $\Omega$		I-II-III	0.2			V
$I_H^*$	$T_j = 25$ $^{\circ}\text{C}$ Gate open	$I_T = 100$ mA $R_L = 140$ $\Omega$					50	mA
$I_L$	$T_j = 25$ $^{\circ}\text{C}$ Pulse duration $> 20$ $\mu\text{s}$	$V_D = 12$ V $I_G = 500$ mA		I-III		50		mA
				II		100		
$V_{TM}^*$	$T_j = 25$ $^{\circ}\text{C}$	$I_{TM} = 8.5$ A	$t_p = 10$ ms				1.75	V
$I_{DRM}^*$	$T_j = 25$ $^{\circ}\text{C}$	$V_{DRM}$ rated Gate open					0.01	mA
	$T_j = 125$ $^{\circ}\text{C}$						2	
$dv/dt^*$	$T_j = 125$ $^{\circ}\text{C}$ Linear slope up to 0.67 $V_{DRM}$	Gate open			500	750		V/ $\mu\text{s}$
$(di/dt)_c^*$	$T_j = 125$ $^{\circ}\text{C}$ Without snubber	$V_{DRM}$ rated			5	10		A / ms
$t_{gt}$	$T_j = 25$ $^{\circ}\text{C}$ $I_T = 8.5$ A	$di_G/dt = 3.5$ A/ $\mu\text{s}$ $V_D = V_{DRM}$	$I_G = 500$ mA	I-II-III		2		$\mu\text{s}$

\* For either polarity of electrode  $A_2$  voltage with reference to electrode  $A_1$ .

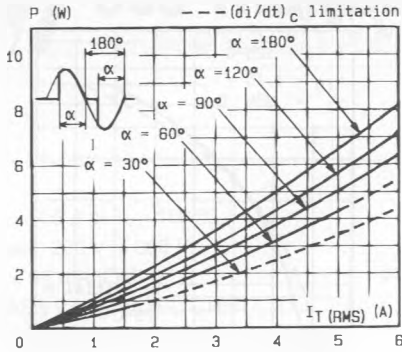


Fig. 1 - Maximum mean power dissipation versus RMS on-state current ( $f = 60$  Hz).

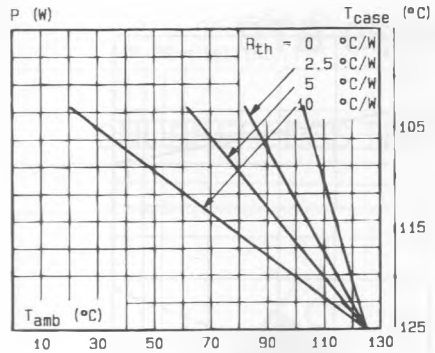


Fig. 2 - Correlation between maximum mean power dissipation and maximum allowable temperatures ( $T_{amb}$  and  $T_{case}$ ) for different thermal resistances heatsink + contact.

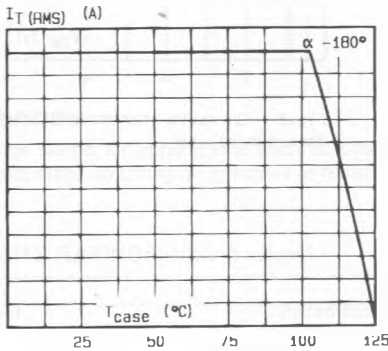


Fig. 3 - RMS on-state current versus case temperature.

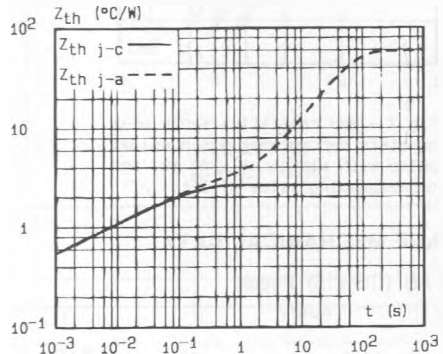


Fig. 4 - Thermal transient impedance junction to case and junction to ambient versus pulse duration.

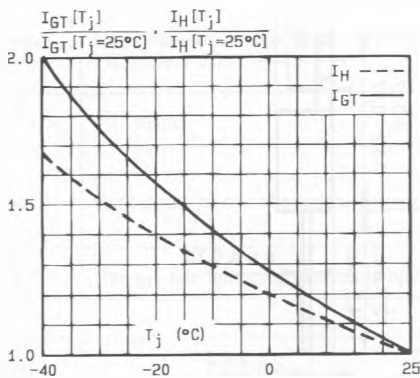


Fig. 5 - Relative variation of gate trigger current and holding current versus junction temperature.

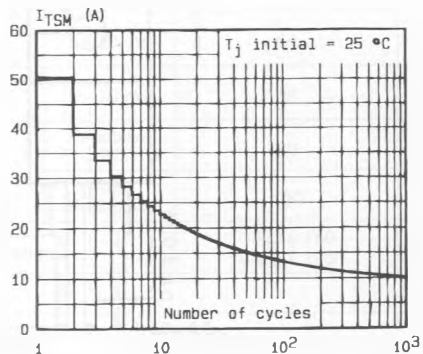


Fig. 6 - Non repetitive surge peak on-state current versus number of cycles.

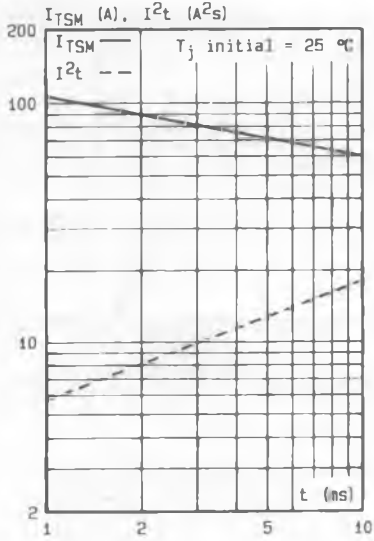


Fig.7 - Non repetitive surge peak on-state current for a sinusoidal pulse with width :  $t \leq 10$  ms, and corresponding value of  $I^2t$ .

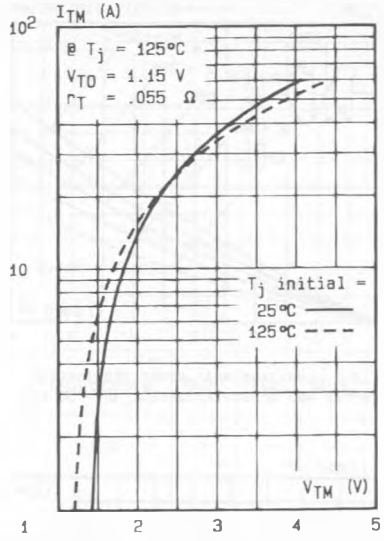
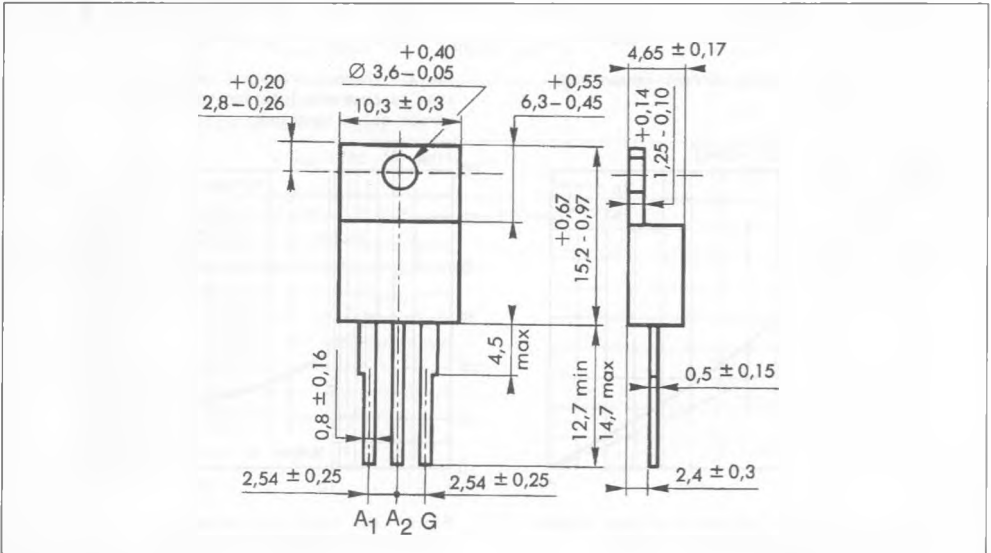


Fig.8 - On-state characteristics (maximum values).

PACKAGE MECHANICAL DATA

TO 220 AB (CB-415) Plastic



Cooling method : by conduction (method C)  
 Marking : type number  
 Weight : 2 g